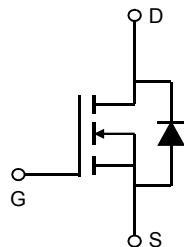
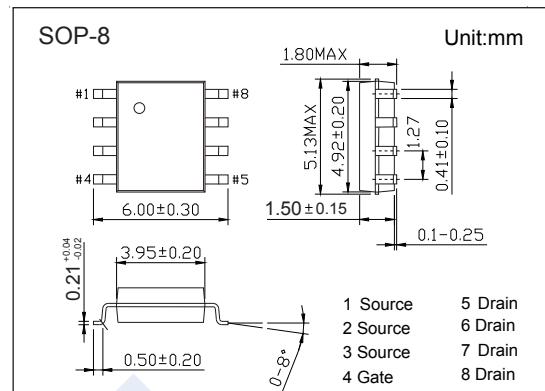


## N-Channel MOSFET

### 2KK5088

#### ■ Features

- $V_{DS} (V) = 30V$
- $I_D = 10 A (V_{GS} = 10V)$
- $R_{DS(ON)} < 12m\Omega (V_{GS} = 10V)$
- $R_{DS(ON)} < 16m\Omega (V_{GS} = 4.5V)$



#### ■ Absolute Maximum Ratings $T_a = 25^\circ C$

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
$V_{DS}$ Spike	$V_{SPIKE}$	36	
Continuous Drain Current	$I_D$	10	A
		6.0	
Pulsed Drain Current	$I_{DM}$	50	
Avalanche Current	$I_{AS}$	15	
Avalanche Energy	$E_{AS}$	11	mJ
Power Dissipation	$P_D$	2.5	W
		1.6	
Thermal Resistance.Junction- to-Ambient	$R_{thJA}$	50	°C/W
		85	
Thermal Resistance.Junction- to-Lead	$R_{thJL}$	30	
Junction Temperature	$T_J$	150	°C
Storage Temperature Range	$T_{stg}$	-55 to 150	

## N-Channel MOSFET

### 2KK5088

■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V <sub>DSS</sub>	I <sub>D</sub> =250 μ A, V <sub>GS</sub> =0V	30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	uA
		V <sub>DS</sub> =30V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C			5	
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	1.0		3.0	V
Static Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =10A			12	m Ω
		V <sub>GS</sub> =10V, I <sub>D</sub> =10A T <sub>J</sub> =125°C			18	
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =8A			16	
Forward Transconductance	g <sub>F</sub>	V <sub>DS</sub> =4.5V, I <sub>D</sub> =8A	15			S
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz		1550		pF
Output Capacitance	C <sub>oss</sub>			300		
Reverse Transfer Capacitance	C <sub>rss</sub>			180		
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	1		3	Ω
Total Gate Charge (10V)	Q <sub>g</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =10A		13		nC
Total Gate Charge (4.5V)				5.8		
Gate Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =10A		5.5		nC
Gate Drain Charge	Q <sub>gd</sub>			3.5		
Turn-On DelayTime	t <sub>d(on)</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =1.25Ω, R <sub>GEN</sub> =3Ω		30		ns
Turn-On Rise Time	t <sub>r</sub>			20		
Turn-Off DelayTime	t <sub>d(off)</sub>			100		
Turn-Off Fall Time	t <sub>f</sub>			80		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 10A, dI/dt= 500A/us		9.7		nC
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			11.5		
Maximum Body-Diode Continuous Current	I <sub>s</sub>				3.5	A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>s</sub> =1A, V <sub>GS</sub> =0V			1	V

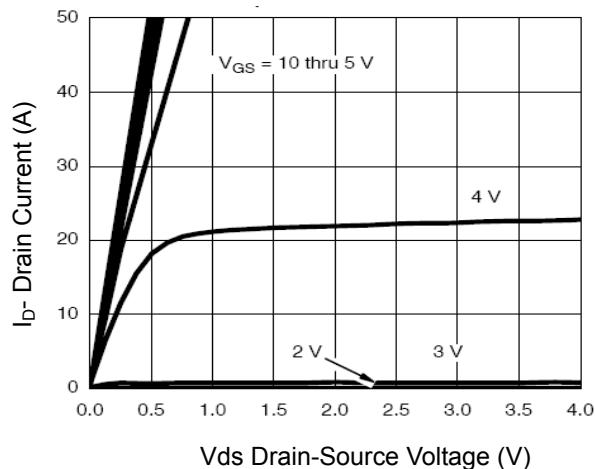
■ Marking

Marking	K5088 KC***
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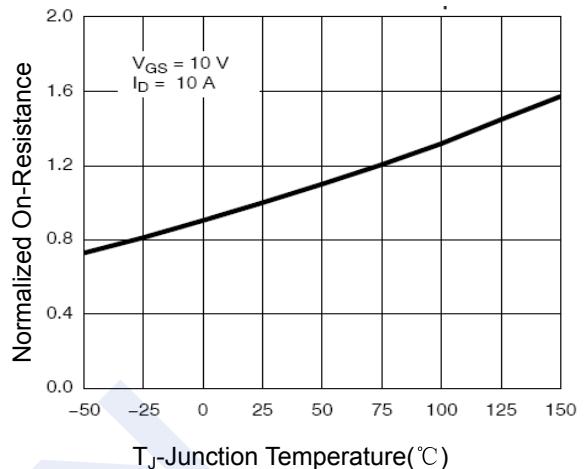
## N-Channel MOSFET

### 2KK5088

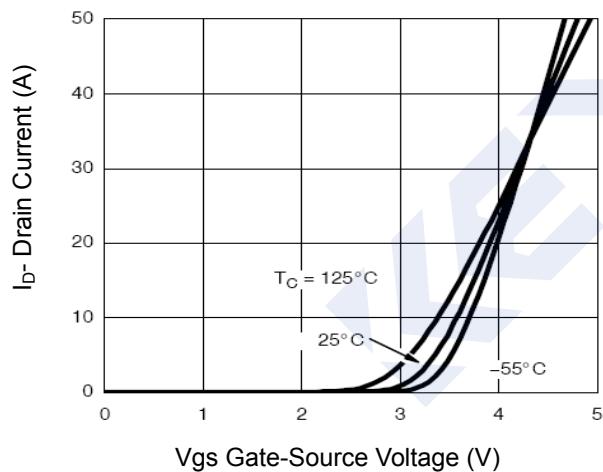
#### ■ Typical Characteristics



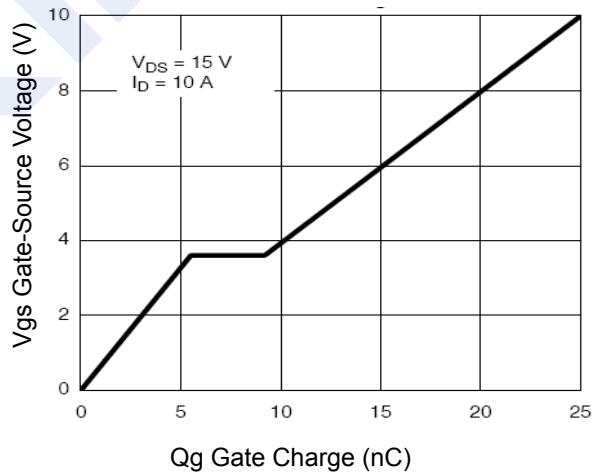
**Figure 1 Output Characteristics**



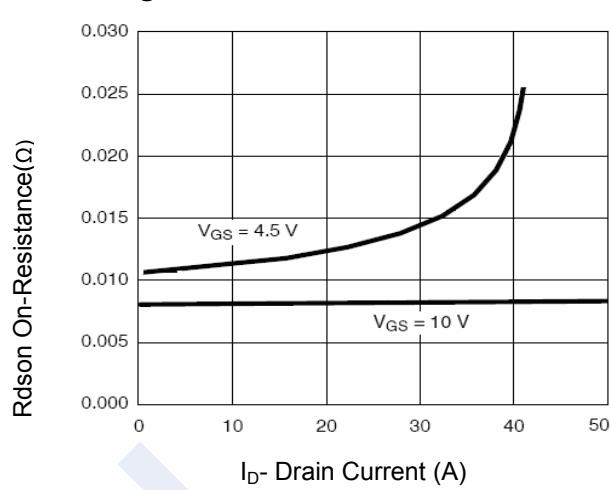
**Figure 4 Rdson-JunctionTemperature**



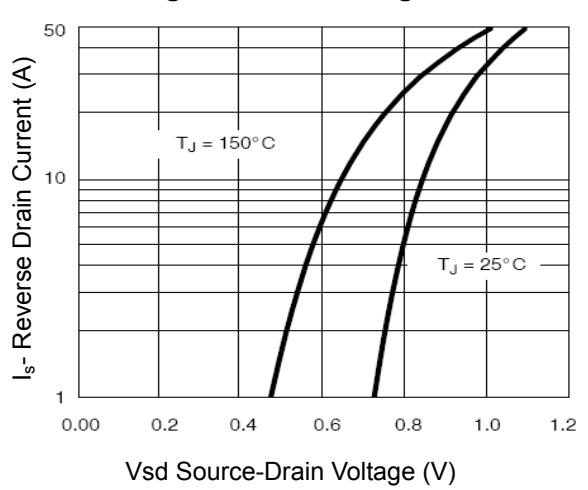
**Figure 2 Transfer Characteristics**



**Figure 5 Gate Charge**



**Figure 3 Rdson- Drain Current**



**Figure 6 Source- Drain Diode Forward**

## N-Channel MOSFET

2KK5088

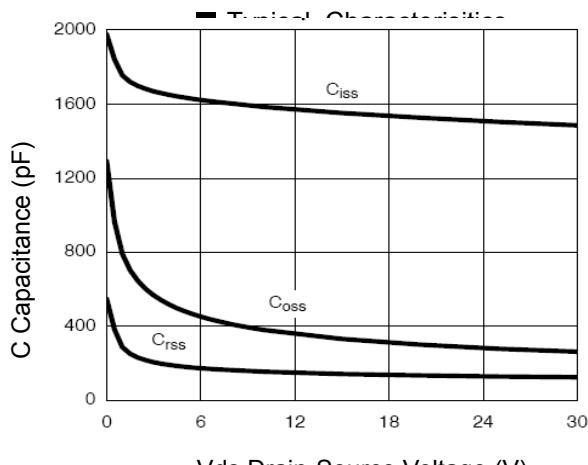


Figure 7 Capacitance vs Vds

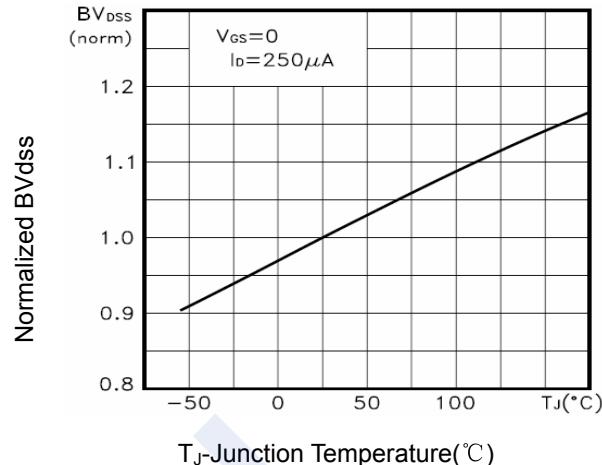


Figure 9  $BV_{dss}$  vs Junction Temperature

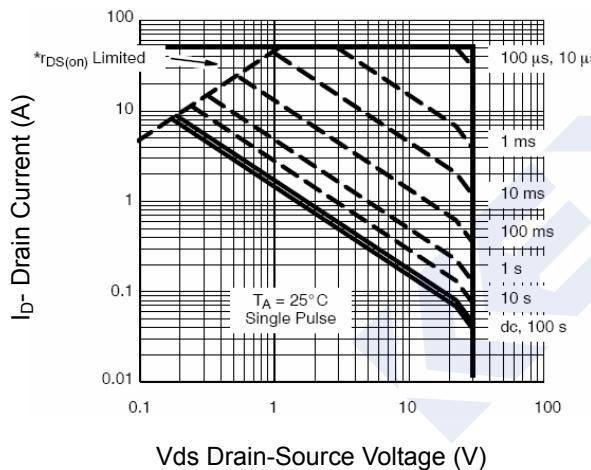


Figure 8 Safe Operation Area

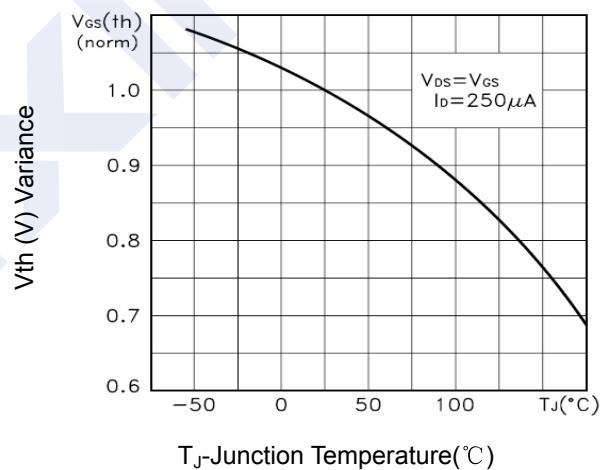


Figure 10  $V_{GS(th)}$  vs Junction Temperature

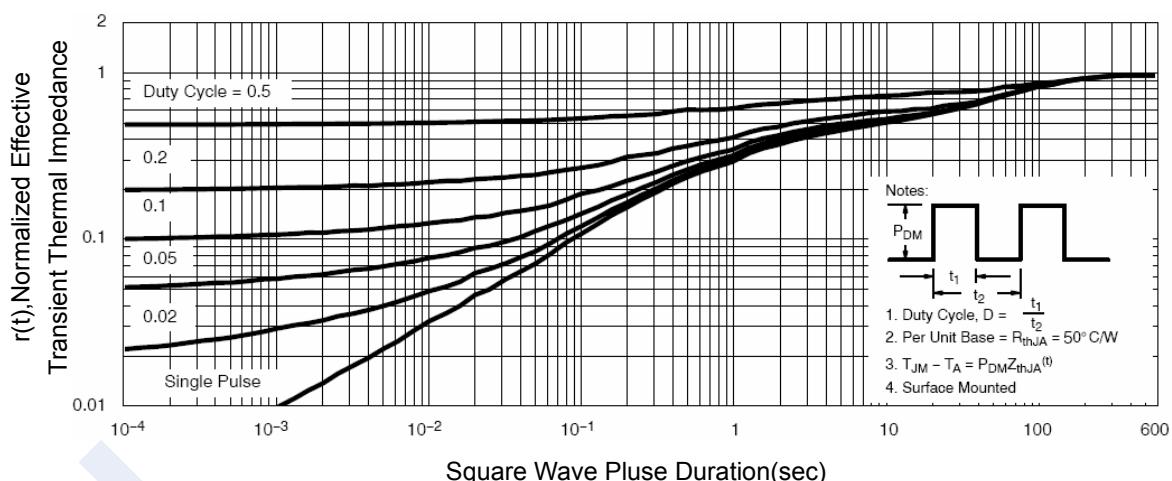


Figure 11 Normalized Maximum Transient Thermal Impedance